Attorney's Docket No.: 12816-021001 / S1166 SB/flu



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Detlef Weber Art Unit : 2814 Serial No. : 09/898,909 Examiner : P. Cao

Filed : July 3, 2001

Title : METALLIZATION ARRANGEMENT FOR SEMICONDUCTOR STRUCTURE

AND CORRESPONDING FABRICATION METHOD

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449. A copy of a communication from a foreign patent office in a counterpart application is also enclosed.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: <u>Deumbe</u> J 2003

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## CERTIFICATE OF MAILING BY FIRST CLASS MAIL

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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 12816-021001

Application No. 09/898,909

## **Information Discl sure Statement** by Applicant

(Use several sheets if necessary)

Filing Date July 3, 2001

Applicant Detlef Weber

> Group Art Unit 2814

(37 CFR §1.98(b))

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	6,268,279	Jul. 31, 2001	Okada			
	AB	5,391,921	Feb. 21, 1995	Kudoh et al.			
	AC						
	AD						
	AE					-	
	AF						
	AG					<del></del>	
	АН						
	AI						
	AJ						
	AK	, , , , , , , , , , , , , , , , , , , ,					7

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Translation	
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	EP 0 550 910 A1	Jul. 14, 1993	Europe			Original in English	
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)			
Examiner Initial	Desig. ID		
	AQ	Patent Abstracts of Japan, Vol. 2000, No. 3, corresponding to JP 11 345875, (1999).	
	AR	Patent Abstracts of Japan, Vol. 2000, No. 4, corresponding to JP 2000 031144, (2000).	
	AS	Patent Abstracts of Japan, Vol. 1996, no. 10, corresponding JP 08 148556, (1996).	
	AT		

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if no next communication to applicant.	t in conformance and not considered. Include copy of this form with